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## Key indicators

Single-crystal X-ray study
$T=140 \mathrm{~K}$
Mean $\sigma(\mathrm{C}-\mathrm{C})=0.006 \AA$
$R$ factor $=0.043$
$w R$ factor $=0.114$
Data-to-parameter ratio $=25.6$
For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.
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## Di- $\mu$-bromo-bis[(methyl isocyanide- $\kappa C$ )-(triphenylphosphine- $\kappa$ P)silver(I)]

The dimeric title molecule, $\left[\mathrm{Ag}_{2} \mathrm{Br}_{2}\left(\mathrm{C}_{2} \mathrm{H}_{3} \mathrm{~N}\right)_{2}\left(\mathrm{C}_{18} \mathrm{H}_{15} \mathrm{P}\right)_{2}\right]$, has crystallographic inversion symmetry. The two bridging $\mathrm{Ag}-$ Br lengths are similar, at 2.7301 (6) and 2.7284 (7) $\AA$.

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## Comment

The title complex, (I), has a center of symmetry, distorted tetrahedral geometry about the Ag atom, and mid-range $\mathrm{Ag}-$ P and $\mathrm{Ag}-\mathrm{C}$ distances. However, the bridging $\mathrm{Ag}-\mathrm{Br}$ distances are more nearly equal than those seen in two other dimeric complexes with bis-triphenylphosphine ligand sets, viz. 2.701 (8)/2.733 (9) $\AA$ (Gotsis et al., 1989) and 2.7350 (6)/ 2.8241 (5) $\AA$ (Cox et al., 2000). The distance between the bridged Ag atoms is 3.5486 (8) $\AA$.

(I)

## Experimental

The title compound crystallized directly from the reaction mixture of $\left[\mathrm{AgBr}\left(\mathrm{PPh}_{3}\right)\right]_{4}$ and four equivalents of methyl isocyanide in methanol.

## Crystal data

| $\left[\mathrm{Ag}_{2} \mathrm{Br}_{2}\left(\mathrm{C}_{2} \mathrm{H}_{3} \mathrm{~N}\right)_{2}\left(\mathrm{C}_{18} \mathrm{H}_{15} \mathrm{P}\right)_{2}\right]$ | $Z=1$ |
| :--- | :--- |
| $M_{r}=982.21$ | $D_{x}=1.706 \mathrm{Mg} \mathrm{m}^{-3}$ |
| Triclinic, $P \overline{1}$ | Mo $K \alpha$ radiation |
| $a=8.3490(17) \AA$ | Cell parameters from 30 |
| $b=9.2120(15) \AA$ | reflections |
| $c=13.8990(15) \AA$ | $\theta=6.4-21.9^{\circ}$ |
| $\alpha=83.301(11)^{\circ}$ | $\mu=3.23 \mathrm{~mm}^{-1}$ |
| $\beta=79.651(13)^{\circ}$ | $T=140(2) \mathrm{K}$ |
| $\gamma=65.499(14)^{\circ}$ | Block, colorless |
| $V=955.8(3) \AA^{\circ}$ | $0.40 \times 0.24 \times 0.15 \mathrm{~mm}$ |
|  |  |
| Data collection |  |
| Siemens $R 3$ diffractometer | $\theta_{\text {max }}=30.0^{\circ}$ |
| $\omega$ scans | $h=-11 \rightarrow 11$ |
| refined from $\Delta F(X A B S 2 ;$ Parkin | $k=-12 \rightarrow 12$ |
| et al., 1995) | $l=0 \rightarrow 19$ |
| $T_{\text {min }}=0.433, T_{\text {max }}=0.619$ | 2 standard reflections |
| 5582 measured reflections | every 198 reflections |
| 5582 independent reflections | intensity decay: $<0.1 \%$ |
| 4498 reflections with $I>2 \sigma(I)$ |  |

$\left[\mathrm{Ag}_{2} \mathrm{Br}_{2}\left(\mathrm{C}_{2} \mathrm{H}_{3} \mathrm{~N}\right)_{2}\left(\mathrm{C}_{18} \mathrm{H}_{15} \mathrm{P}\right)_{2}\right]$
$M_{r}=982.21$
Triclinic, $P 1$
(17) A
$b=9.2120$ (15) A
$\alpha=83.301$ (11) ${ }^{\circ}$
$\beta=79.651(13)^{\circ}$
$\gamma=65.499(14)^{\circ}$

## Data collection

siemens R3 diffractometer
refined from $\triangle F(X A B S 2$; Parkin
et al., 1995)
$T_{\min }=0.433, T_{\max }=0.619$
5582 independent reflections
4498 reflections with $I>2 \sigma(I)$

$$
\begin{aligned}
& Z=1 \\
& D_{x}=1.706 \mathrm{Mg} \mathrm{~m}^{-3} \\
& \text { Mo } K \alpha \text { radiation } \\
& \text { Cell parameters from } 30 \\
& \quad \text { reflections } \\
& \theta=6.4-21.9^{\circ} \\
& \mu=3.23 \mathrm{~mm}^{-1} \\
& T=140(2) \mathrm{K} \\
& \text { Block, colorless } \\
& 0.40 \times 0.24 \times 0.15 \mathrm{~mm} \\
& \\
& \theta_{\text {max }}=30.0^{\circ} \\
& h=-11 \rightarrow 11 \\
& k=-12 \rightarrow 12 \\
& l=0 \rightarrow 19 \\
& 2 \text { standard reflections } \\
& \text { every } 198 \text { reflections } \\
& \text { intensity decay: }<0.1 \%
\end{aligned}
$$

## Refinement

Refinement on $F^{2}$

$$
\begin{aligned}
& w=1 / {\left[\sigma^{2}\left(F_{o}^{2}\right)+(0.0565 P)^{2}\right.} \\
&+2.5564 P] \\
& \text { where } P=\left(F_{o}^{2}+2 F_{c}^{2}\right) / 3 \\
&(\Delta / \sigma)_{\max }=0.001 \\
& \Delta \rho_{\max }=1.30 \mathrm{e}^{-3} \\
& \Delta \rho_{\min }=-1.58 \mathrm{e} \mathrm{~A}^{-3}
\end{aligned}
$$

$w R\left(F^{2}\right)=0.114$
$S=1.04$
5582 reflections
218 parameters H -atom parameters constrained


Figure 1
A view of (I). Displacement ellipsoids are drawn at the $50 \%$ probability level. H atoms have been omitted. Primed atom labels correspond to symmetry code (i) in Table 1.

## References

Cox, P. J., Aslanidis, P., Karagiannidis, P. \& Hadjikakou, S. (2000). Inorg. Chim. Acta, 310, 268-272.
Gotsis, S. L. M., Engelhardt, L. M., Healy, P. C., Kildea, J. D. \& White, A. H. (1989). Aust. J. Chem. 42, 923-931.

Parkin, S., Moezzi, B. \& Hope, H. (1995). J. Appl. Cryst. 28, 53-56.
Sheldrick, G. M. (1994). SHELXTL. Version 5.1. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.
Sheldrick, G. M. (1997). SHELXS97 and SHELXL97. University of Göttingen, Germany.
Siemens (1991). P3-PC (Version 4.23) and XDISK. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.

